



In situ X-ray area detector flat-field correction at an operating photon energy without flat illumination. Corrigendum

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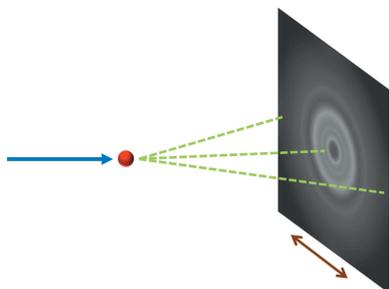
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The name of an author in the article by Weng *et al.* (2023) [*J. Synchrotron Rad.* **30**, 546–554] is corrected.

The name of the fifth author in the article by Weng *et al.* (2023) is incorrectly given as Jahui Chen. The correct spelling is Jiahui Chen, as given above.

References

Weng, J., Xu, W., Wiaderek, K. M., Borkiewicz, O. J., Chen, J., Von Dreele, R. B., Gallington, L. C. & Ruett, U. (2023). *J. Synchrotron Rad.* **30**, 546–554.



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